

### KGF16N05D

N-Channel 5.5V Dual Power MOSFET

FN8810 Rev 0.00 January 27, 2016

The KGF16N05D is a dual 5.5V, 1.9m $\Omega$ , chip-scale, N-channel Power MOSFET. The device uses technology that uniquely integrates low cost CMOS and WLCSP fabrication processes. The chip scale package offers small area, low vertical profile and is fully compatible with standard SMT assembly processes. The KGF16N05D device offers unprecedented low on-resistance and total gate charge, outperforming conventional trench MOSFETs and enabling high frequency, low voltage switching. The device offers extremely high power density, reducing the board size of DC/DC converters and other power management systems.

PRODUCT SUMMARY (PER FET)			
I <sub>D</sub>	T <sub>A</sub> = +25°C	8A	Maximum
V <sub>(BR)DSS</sub>	I <sub>D</sub> = 5mA	5.5V	Minimum
r <sub>DS(ON)</sub>	V <sub>GS</sub> = 4.5V	1.9mΩ	Typical
r <sub>DS(ON)</sub>	V <sub>GS</sub> = 4.5V (in Parallel)	0.95mΩ	Typical
Qg	V <sub>GS</sub> = 4.5V	5.5nC	Typical
$Q_{gd}$ $I_D = 4A$		0.9nC	Typical

#### **Features**

- Industry leading figures of merit:
   r<sub>DS(ON)</sub> × Q<sub>g</sub> and r<sub>DS(ON)</sub> × Q<sub>gd</sub>
- · Low profile/small footprint chip scale WLCSP package
- · High frequency switching
- Known Good FET (KGF) Quality Assurance Process
- · Low thermal resistance

### **Applications**

- · Point-of-load DC/DC converters
- · Portable electronics
- · OR'ing diodes

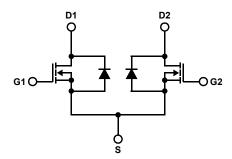


FIGURE 1. EQUIVALENT CIRCUIT

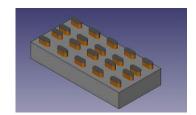


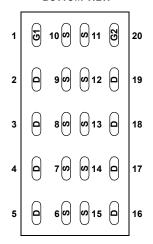
FIGURE 2. WLCSP, DIE SIZE 2.475mm x 1.170mm

# **Ordering Information**

PART NUMBER	PART MARKING	TEMP RANGE (°C)	PACKAGE (RoHS Compliant)
KGF16N05D-400	AM	-55°C to +150°C	20 Bump WLCSP

# **Pin Configuration**

KGF16N05D (20 BUMP WLCSP) BOTTOM VIEW



# **Pin Descriptions**

PIN#	PIN NAME	DESCRIPTION
1	G1	Gate of MOSFET 1
2, 3, 4, 5	D1	Drain of MOSFET 1
6, 7, 8, 9, 10, 11, 12, 13, 14, 15	S	Source of both MOSFETs
16, 17, 18, 19	D2	Drain of MOSFET 2
20	G2	Gate of MOSFET 2

#### Absolute Maximum Ratings (Note 1)

Drain-to-Source Voltage (V <sub>DS</sub> )	5.5V
Gate-to-Source Voltage (V <sub>GS</sub> )	±5.5V
Drain Current (I <sub>D1</sub> + I <sub>D2</sub> )	
Continuous (I <sub>D</sub> )	16A
Pulsed (I <sub>DM</sub> )	40A
Single Pulse Avalanche Current (I <sub>AS</sub> ), (I <sub>D1</sub> + I <sub>D2</sub> )	
$L \le 50 \mu H, R_G \le 25 \Omega.$	10A

#### **Thermal Information**

Thermal Resistance (Typical) (Note 2)	$\theta_{JA}(^{\circ}C/W)$	$\theta_{JP}(^{\circC/W})$
WLCSP Package	50	10
Maximum Power Dissipation (PD) (Note 2)		
T <sub>A</sub> = +25°C		2.5W
$T_A = +70$ °C		1.6W
Junction and Storage Temperature Range (T	, T <sub>stg</sub> )5!	5°C to +150°C
Pb-Free Reflow Profile		see <u>TB493</u>

CAUTION: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions may adversely impact product reliability and result in failures not covered by warranty.

#### NOTES:

- 1.  $T_J = +25$ °C unless otherwise noted.
- 2. When mounted on 1 inch square 2oz copper clad FR-4.

### $\textbf{Electrical Characteristics} \quad \text{Specifications are for single MOSFET unless otherwise specified.} \ T_J = +25\,^{\circ}\text{C unless otherwise noted.}$

SYMBOL	PARAMETER	TEST CONDITIONS	MIN (Note 3)	TYP	MAX (Note 3)	UNIT
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 5mA	5.5			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 4V, V_{GS} = 0V, T_J = +25 ^{\circ}C$			0.01	mA
		$V_{DS} = 5V$ , $V_{GS} = 0V$ , $T_{J} = +25 ^{\circ}C$			0.1	mA
		$V_{DS} = 5V$ , $V_{GS} = 0V$ , $T_J = +125$ °C			1.0	mA
I <sub>GSS</sub>	Gate-to-Body Leakage	V <sub>GS</sub> = 5.5V, V <sub>DS</sub> = 0V			75	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.6	0.7	0.9	V
r <sub>DS(ON)</sub>	Drain-to-Source On-State Resistance	V <sub>GS</sub> = 3.5V, I <sub>D</sub> = 8A		2.1		mΩ
	(per MOSFET)	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 8A		1.9		mΩ
r <sub>DS(ON)</sub>	Drain-to-Source On-State Resistance	V <sub>GS</sub> = 3.5V, I <sub>D</sub> = 8A		1.05		mΩ
	(in Parallel)	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 8A		0.95		mΩ
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 5V, V <sub>GS</sub> = 0V, f = 1MHz		600		pF
C <sub>oss</sub>	Output Capacitance			840		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			215		pF
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 0V, V <sub>GS</sub> = 0V, f = 1MHz		660		pF
C <sub>oss</sub>	Output Capacitance			1130		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			265		pF
Rg	Gate Resistance	V <sub>DS</sub> = 0V, f = 1MHz		1.0		Ω
Qg	Total Gate Charge	$V_{GS} = 3.5V$ , $I_D = 4A$ , $V_{DS} = 4V$		4.3		nC
Qgs	Gate-to-Source Charge			0.6		nC
Q <sub>gd</sub>	Gate-to-Drain Charge			0.9		nC
Qg	Total Gate Charge	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 4A, V <sub>DS</sub> = 4V		5.5		nC
t <sub>rr</sub>	Source-to-Drain Reverse Recovery Time	$I_S = 3A$ , $di/dt = 33A/\mu s$		69		ns
V <sub>SD</sub>	Diode Forward Voltage	$I_S = 5A$ , $V_{GS} = 0V$		0.65	1.00	V

#### NOTE:

3. Compliance to datasheet limits is assured by one or more methods: production test, characterization and/or design.



## **Typical Performance Curves**

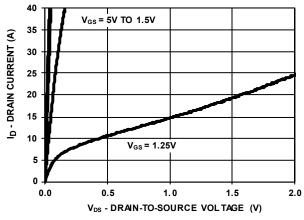


FIGURE 3. OUTPUT CHARACTERISTICS

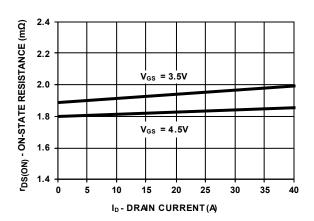


FIGURE 5. DRAIN-TO-SOURCE ON-STATE RESISTANCE vs DRAIN CURRENT

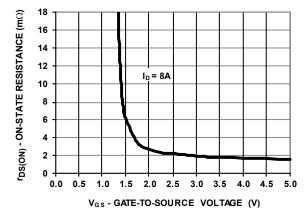
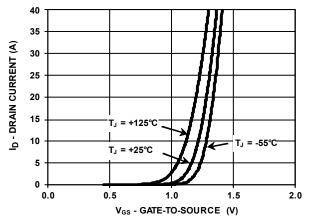


FIGURE 7. DRAIN-TO-SOURCE ON-STATE RESISTANCE vs GATE-TO-SOURCE VOLTAGE



**FIGURE 4. TRANSFER CHARACTERISTICS** 

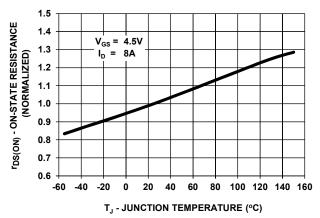


FIGURE 6. DRAIN-TO-SOURCE ON-STATE RESISTANCE vs JUNCTION TEMPERATURE

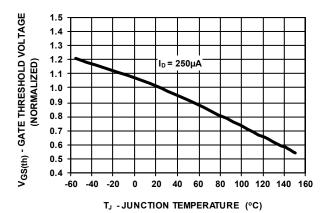


FIGURE 8. GATE THRESHOLD VOLTAGE vs JUNCTION TEMPERATURE

## Typical Performance Curves (Continued)

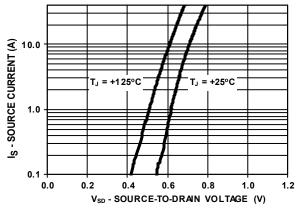


FIGURE 9. SOURCE-TO-DRAIN DIODE FORWARD VOLTAGE

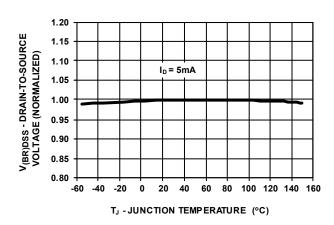
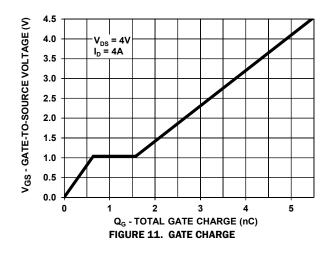


FIGURE 10. DRAIN-TO-SOURCE BREAKDOWN VOLTAGE vs JUNCTION TEMPERATURE



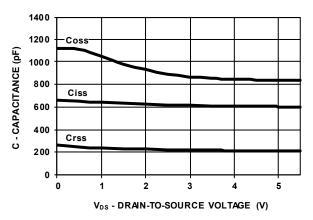


FIGURE 12. CAPACITANCE

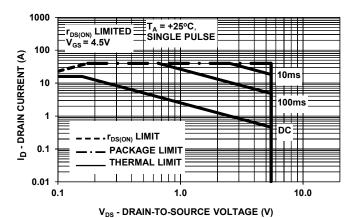


FIGURE 13. MAXIMUM RATED FORWARD BIASED SAFE OPERATING AREA (IN PARALLEL)

# Typical Performance Curves (Continued)

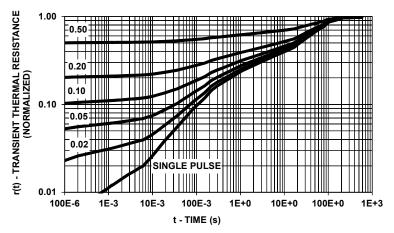


FIGURE 14. TRANSIENT THERMAL RESPONSE, JUNCTION-TO-AMBIENT (IN PARALLEL)

### **Revision History**

The revision history provided is for informational purposes only and is believed to be accurate, but not warranted. Please go to the web to make sure that you have the latest revision.

	DATE	REVISION	CHANGE
Ī	January 27, 2016	FN8810.0	Initial release

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### **Dimensional Outline and Pad Layout**

Side View



